Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/617,232	ROSHDIEH ET AL.	OSHDIEH ET AL	
Examiner	Art Unit	rt Unit	
Jeffrey G. Hoekstra	3736	736	

	SEARCHED			
Class	Subclass	Date	Examiner	
600	564	10/11/2005	JGH	
600	566	10/11/2005	JGH	
600	567	10/11/2005	JGH	
600	565	10/11/2005	JGH	
606	180	10/7/2005	JGH	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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